

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner	Art Unit		
Derek L. Dupuis	2883		Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0181900 A1	12-2002	Loch et al.	385/92
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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